# Verification of Compliance

**Product Name** 

**Audio Distribution System** 

**Brand Name** 

Model No.

: AD-8x

Applicant

: Remote Technologies Inc.

Address

: 5775 12<sup>th</sup> Ave. East, Suite 180, Shakopee, MN55379, U.S.A.

Report Number

: O13-I210-1301-212

Issue Date

: April 3, 2013

Applicable Standards: EN 55013:2001+A1:2003+A2:2006

AS/NZS CISPR13:2004

EN 61000-3-2:2006 +A1:2009 +A2:2009

EN 61000-3-3:2008

EN 55020:2007+A11:2011

IEC 61000-4-2:2008

IEC 61000-4-4:2004+A1:2010

Based on the EMC Directive 2004/108/EC and the specifications of the customer, one sample of the designated product has been tested in our laboratory and found to be in compliance with the EMC standards cited above.



TAF 0905 FCC CAB Code TW1053 NVLAP Lab Code 200575-0 IC Code 4699A VCCI Accep. No. R-1527, C-1609, T-1441, G-10,

C-4400, G-614, T-1334

Central Research Technology Co.

**EMC Test Laboratory** 11, Lane41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. Tel: 886-2-25984568

Fax: 886-2-25984546

(Tsun-Yu Shih/ General Manager)

Date: April 3, 2013

# **CE EMC Test Report**

for

## **Audio Distribution System**

Trade Name :

Model Number : AD-8x

Report Number : 013-I210-1301-212

Date of Receipt : February 25, 2013

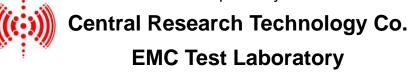
Date of Report : April 3, 2013

#### Prepared for

## Remote Technologies Inc.

5775 12<sup>th</sup> Ave. East, Suite 180, Shakopee, MN55379, U.S.A.

Prepared by



11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

This report shall not be reproduced, except in full, without the written approval of Central Research Technology Co.. It may be duplicated completely in its entirely for legal use with the permission of the applicant. The test result in the report applies only to the sample tested.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## Verification of Compliance

**Equipment Under Test** : Audio Distribution System

Model No. : AD-8x

: Remote Technologies Inc. **Applicant** 

: 5775 12<sup>th</sup> Ave. East, Suite 180, Shakopee, MN55379, U.S.A. **Address** 

: EN 55013:2001+A1:2003+A2:2006 Applicable Standards

AS/NZS CISPR13:2004

EN 61000-3-2:2006 +A1:2009 +A2:2009

EN 61000-3-3:2008

EN 55020:2007+A11:2011

IEC 61000-4-2:2008

IEC 61000-4-4:2004+A1:2010

( + )

Date of Testing : February 28~March 22, 2013

Deviation : N/A

**Condition of Test Sample**: Pre-production Sample

We, Central Research Technology Co., hereby certify that one sample of the designated product was tested in our facility during the period mentioned above. The test records, data evaluation and Equipment Under Test (EUT) configurations shown in the present report are true and accurate representation of the measurements of the sample's EMC characteristics under the conditions herein specified.

The test results show that the EUT as described in the present report is in compliance with the requirements set forth in the standards mentioned above and apply to the tested sample identified in the present report only. The test report shall not be reproduced, except in its entirety, without the written approval of Central Research Technology Co.

PREPARED BY

Rosa Hsieh/System Executive), DATE: April 3, >013

(Rosa Hsieh/System Executive), DATE: Apr. 3, >0/3 APPROVED BY

(Tsun-Yu Shih/General Manager)

## **Contents**

1. Gene	eral Description	6
1.1	General Description of EUT	6
1.2	Test Mode	7
1.3	Applied standards	8
1.4	Test Setup for the EUT	9
1.5	The Support Units	10
1.6	Layout of the Setup	11
1.7	Test Capability	14
2. Cond	ducted Emission Measurement	16
2.1	Limits for Emission Measurement	16
2.2	Test Instruments	17
2.3	Test Procedures	19
2.4	Test Configurations	20
2.5	Photographs of the Test Configurations	20
2.6	Test Results	21
3. Distu	ırbance Power Measurement	23
3.1	Limits for Emission Measurement	23
3.2	Test Instruments	24
3.3	Test Procedures	26
3.4	Test Configurations	27
3.5	Photographs of the Test Configurations	27
3.6	Test Results	28
4. Harm	nonic Current Emission Measurement	34
4.1	Limits for Emission Measurement	34
4.2	Test Instruments	35
4.3	Test Procedures	36
4.4	Test Configurations	37
4.5	Photographs of the Test Configurations	37
4.6	Test Results	38

<b>5</b> .	Volta	ge Fluctuations and Flickers Emission Measurement	40
	5.1	Limits for Emission Measurement	40
	5.2	Test Instruments	40
	5.3	Test Procedures	41
	5.4	Test Configurations	42
	5.5	Photographs of the Test Configurations	42
	5.6	Test Results	43
6.	Immu	ınity Against RFI Voltage(S2a)	44
	6.1	Limits for Immunity Measurement	44
	6.2	Description of Performance Criteria	45
	6.3	Test Instruments	46
	6.4	Test Procedures	47
	6.5	Test Configurations	48
	6.6	Photographs of the Test Configurations	48
	6.7	Test Results	49
7.	Immu	ınity Against Radiated RFI (S3)	67
	7.1	Limits for Immunity Measurement	67
	7.2	Description of Performance Criteria	68
	7.3	Test Instruments	69
	7.4	Test Procedures	70
	7.5	Test Configurations	71
	7.6	Photographs of the Test Configurations	71
	7.7	Test Results	72
8.	Keye	d Carrier(S5)	74
	8.1	Limits for Immunity Measurement	74
	8.2	Description of Performance Criteria	75
	8.3	Test Instruments	76
	8.4	Test Procedures	78
	8.5	Test Setup	79
	8.6	Photographs of the Test Configurations	79
	8.7	Test Results	80

9.	Electr	ostatic Discharge (ESD) Immunity Test	82
	9.1	Specifications of Immunity Test Requirement	82
	9.2	Description of Performance Criteria	83
	9.3	Test Instruments	84
	9.4	Test Procedures	85
	9.5	Test Configurations	87
	9.6	Photographs of the Test Configurations	87
	9.7	Test Results	88
10.	Elect	rical fast transient / burst (EFT) Immunity Test	92
	10.1	Specifications of Immunity Test Requirement	92
	10.2	Description of Performance Criteria	93
	10.3	Test Instruments	94
	10.4	Test Procedures	95
	10.5	Test Configurations	96
	10.6	Photographs of the Test Configurations	96
	10.7	Test Results	97
Δtt	achm	ent 1 – Photographs of the Test Configurations	

Attachment 2 – Photographs of EUT

## 1. General Description

## 1.1 General Description of EUT

Equipment Under Test: Audio Distribution System

Model No. : AD-8x

Power in : 230V/50Hz

Manufacturer : Amcli International Corp.

Function Description :

The EUT is a Pre-production Sample of the Audio Distribution System. Please refer to the user's manual for the details.

The I/O ports of EUT are listed below:

NO.	I/O Port Type	Quantity
1	ZONE SOURCE L&R	8 set
2	ZONE LOOP OUT L&R	8 set
3	ZONE PRE-OUT L&R	8 set
4	ZONE SPEAKERS OUT L&R	8 set
5	RS232	1
6	CTRL IN	1
7	CTRL OUT	1
8	MUTE	1
9	STATUS	1
10	ETHERNET	1
11	REMOTE SOURCE IR INPUT1~4,ALL	1
12	REMOTE SOURCE 1~4	1
13	+12VDC	1

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Page : 7 / 97

## 1.2 Test Mode

Normal operating as the specification of manufacturer.

CENTRAL RESEARCH TECHNOLOGY CO. 11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 1.3 Applied standards

According to the specifications of the manufacturer and the requirements set in European Council EMC Directive 2004/108/EC, the applied standards to evaluate the compliance of the EUT are as following:

Appli	ed Standards	Test Items	Results
		☑ Conducted Emission	DACC
		Measurement	<u>PASS</u>
		☑ Disturbance Power	DACC
☑ EN55013: 2001+A	11:2002±42:2006	Measurement	<u>PASS</u>
☑ EN33013. 2001+7		☐ Radiated Emission	NI/A
M AS/NZS CISER I	3.2004	Measurement	<u>N/A</u>
		☐ Disturbance Voltage at the	
		Antenna Terminals	<u>N/A</u>
		Measurement	
[7] EN 61000 3 2:200	06 +A1:2009 +A2:2009	Harmonic Current Emission	DV66
EN 01000-3-2.200	00 +A1.2009 +A2.2009	Measurement	<u>PASS</u>
☑ EN 61000-3-3:200	10	Voltage Fluctuation and Flicker	DAGG
EN 01000-3-3.200	70	Emission Measurement	<u>PASS</u>
		☐ Immunity Against Input	NI/A
		Interference (S1)	<u>N/A</u>
		☑ Immunity Against RFI	PASS
		Voltage(S2a)	FASS
		☐ Immunity Against RFI	N/A
		Current(S2b)	<u>1N//A</u>
☑ EN 55020:2007+A	11.2011	☑ Immunity Against Radiated	PASS PASS
E EN 00020.2007 17		RFI (S3)	<u>1 700</u>
		☐ Screening Effectiveness	N/A
		(S4)	14// (
		☑ Keyed Carrier(S5)	<u>PASS</u>
		☐ Immunity from Radiated	
		field not fitting inside the	<u>N/A</u>
		open strip line (S6)	
	☑ IEC 61000-4-2:2008	Electrostatic discharge Test	<u>PASS</u>
☑ EN 55020:	E 120 0 1000 7 2.2000	(ESD)	17100
2007+A11:2011	☑ IEC 61000-4-4:2004	Electrical fast transient / burst	<u>PASS</u>
	+A1:2010	immunity Test (EFT)	17.00

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 1.4 Test Setup for the EUT

The EUT is an unique unit connected with other necessary accessories and support units listed in the next section. It has been tested against each standard after the following setup steps:

#### EN 55013, EN 61000-3-2, EN 61000-3-3, ESD and EFT

- a. Connect the EUT and all the support units to the appropriate power source.
- b. Turn on the EUT and all the accessories and support units.
- c. The DVD player sends 1kHz audio signal to the speakers by the EUT.
- d. Adjust the speaker output of the EUT to 1/8 rated power.
- e. Repeat and keep the setup steps listed above before and during all tests.

### EN 55020 (S2a, S3, S5)

- a. Connect the EUT and all the support units to the appropriate power source.
- b. Turn on the EUT and all the accessories and support units.
- c. The TS9980 TV sound test signal system plays the wanted and unwanted signals to the EUT.
- d. Repeat and keep the setup steps listed above before and during all tests.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 1.5 The Support Units

#### EN 55013

No.	Unit	Model No./ Serial No.	FCC ID	Trade Name	Power Cord	Supported by lab.
1	DVD Player	KVD-1080/ 0601000119	N/A	KOLIN	1.4m	<b>✓</b>
2	Speaker	A215/ CN-0Y09266-69804- 5B6-0346	DoC	DELL	1.8m	<b>√</b>
3	Speaker	SP-600R/ 70503509	N/A	TATUNG	N/A	✓

## EN 61000-3-2, EN 61000-3-3, ESD and EFT

No.	Unit	Model No./ Serial No.	FCC ID	Trade Name	Power Cord	Supported by lab.	
1	DVD Player	KVD-1080/	N/A	KOLIN	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	<b>✓</b>	
<u>'</u>	DVD Flayei	0601000119	IN/A	KOLIN	1.4m	•	
		A215/					
2	Speaker	CN-0Y09266-69804-	DoC	DELL	1.8m	✓	
		5B6-0346					
2	Speaker	SP-600R/	N/A	TATUNG	N/A	<b>✓</b>	
3		70503509	IN/A	IATONG	IN/A	•	

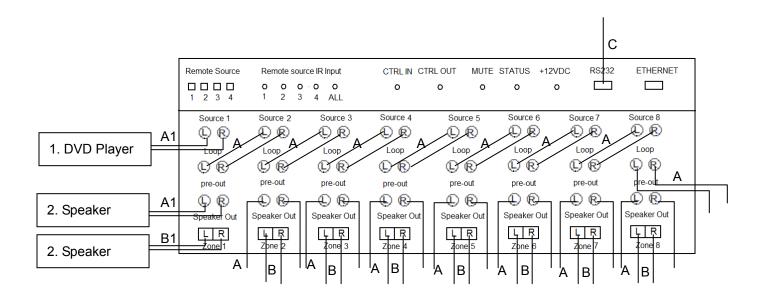
## EN 55020 (S2a, S3, S5)

No.	Unit	Model No./ Serial No.	FCC ID	Trade Name	Power Cord	Supported by lab.
1	DVD Player	KVD-1080/ 0601000119	N/A	KOLIN	1.4m	✓

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 1.6 Layout of the Setup

## Conducted Emission, EN 61000-3-2, EN 61000-3-3, ESD and EFT

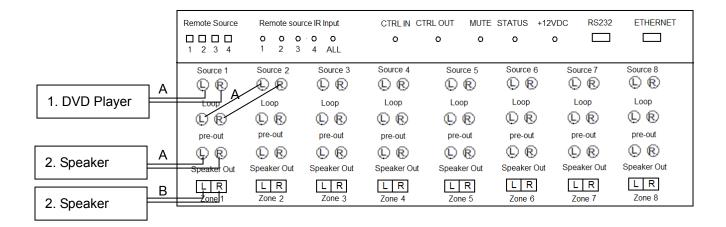


## **Connecting Cables:**

No.	Cable	Length	Shielded	Core	Shielded Backshell	Supported by lab.	Note
Α	AV*2 Cable	1.2m	✓			✓	Floating
A1	AV 2 Cable	1.2m	<b>✓</b>	✓		✓	Hitching Core
В	Audio Cable	1.2m	✓			<b>✓</b>	Floating
B1	Audio Cable	1.2m	<b>✓</b>	<b>√</b>		<b>✓</b>	Hitching Core
С	RS232 Cable	1.8m	✓	✓		<b>✓</b>	Hitching Core Floating

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### **Disturbance Power Test**

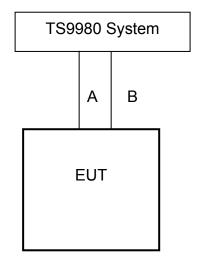


## **Connecting Cables:**

No.	Cable	Length	Shielded	Core	Shielded Backshell	Supported by lab.	Note
Α	AV*2 Cable	21m	<b>✓</b>	✓		<b>✓</b>	Adding Core
В	Audio Cable	8m	<b>✓</b>	✓		<b>✓</b>	Adding Core

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## EN 55020 (S2a, S3, S5)



## **Connecting Cables:**

No.	Cable	Length	Shielded	Core	Shielded Backshell	Supported by lab.	Note
Α	AV*2 cable	1.2m	<b>√</b>			✓	
В	Signal Cable	>3m	<b>√</b>			✓	

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 1.7 Test Capability

## **Test Facility**

The test facility used for evaluating the conformance of the EUT with each standard in the present report meets what required in CISPR16-1-4, CISPR16-2-3.

Test Room	Type of Test Room	Descriptions
TR1	10m semi-anechoic chamber (23m×14m×9m)	Complying with the NSA requirements in
TR1	3m fullly-anechoic chamber (23m×14m×9m)	Complying with the NSA requirements in documents CISPR 22/ EN 55022 for the radiated emission measurement.
TR11	3m semi-anechoic chamber (9m×6m×6m)	
TR5	Shielding Room (8m×5m×4m)	For the conducted emission measurement.
TR4	Shielding Room (5m×3m×3m)	Tor the conducted emission measurement.
TR2	3m fully-anechoic chamber (7m×3m×3m)	Complying with the field uniformity requirements in standard IEC/ EN 61000-4-3 for the radiated immunity test.
TR7	Shielding Room (5m×3m×3m)	
TR8	Shielding Room (5m×3m×3m)	For the Current Harmonic / Voltage Flicker and other immunity tests.
AR	Shielding Room (3m×3m×3m)	
TR20	Shielding Room (8.5m×4m×2.5m)	For Input Immunity (S1) Immunity from conducted Voltage (S2a) Immunity to RF voltages (common mode) of antenna terminals (S2b) Immunity from Radiated field(S3) Screening Effectiveness (S4)
TR300	3m fully-anechoic chamber (8m×5m×5m)	Complying with the site VSWR requirements set in documents CISPR 16-1-4 for the radiated emission measurement.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## **Test Laboratory Competence Information**

Central Research Technology Co. has been accredited / filed / authorized by the agencies listed in the following table.

Certificate	Nation	Agency	Code	Mark
	USA	NVLAP	200575-0	ISO/IEC 17025
	R.O.C. (Taiwan)	TAF	0905	ISO/IEC 17025
Accreditation Certificate	R.O.C. (Taiwan)	BSMI	SL2-IN-E-0033, SL2-IS-E-0033, SL2-R1/R2-E-0033, SL2-A1-E-0033 SL2-L1-E-0033	ISO/IEC 17025
	USA	FCC	474046,TW1053	Test facility list & NSA Data
Site Filing Document	Canada	IC	4699A-1,-3	Test facility list & NSA Data
	Japan VCCI		R-1527,C-1609,T-1441,G-10, C-4400, G-614, T-1334	Test facility list & NSA Data
Authorization	Germany	TUV	10021687	ISO/IEC 17025
Certificate	Norway	Nemko	ELA 212	ISO/IEC 17025

The copy of each certificate can be downloaded from our web site: www.crc-lab.com

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 2. Conducted Emission Measurement

Test Result : PASS

#### 2.1 Limits for Emission Measurement

## ☑ Limits for conducted disturbances at the power mains

Frequency (MHz)	Quasi-peak (dBµV)	Average (dBμV)
0.15 to 0.5	66 – 56	56 – 46
0.5 to 5	56	46
5 to 30	60	50

Note 1- The lower limit shall apply at the transition frequency.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Note 2- The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5MHz for Class B equipment.

#### **Test Instruments** 2.2

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Manufacturei	Serial No.	<b>Calibration Date</b>	Due Date	
Test Receiver	R&S	ESCS 30/	Jan. 14, 2013	lon 14 2014	
lest Receiver	Κασ	836858/021	Jan. 14, 2013	Jan. 14, 2014	
LISN	R&S	ESH2-Z5/	June 5, 2012	June 5, 2013	
LISIN	Κασ	836613/001	Julie 5, 2012	Julie 5, 2015	
2 <sup>nd</sup> LISN	R&S	ENV4200/	March 26, 2012	March 26, 2012	
Z LISIN	Κασ	833209/010	Watch 20, 2012	March 26, 2013	
50Ω terminator	N/A	N/A/	Aug. 20, 2012	Aug. 20, 2013	
5012 terminator	IN/A	001	Aug. 20, 2012		
RF Switch	R&S	RSU28/	Feb. 19, 2013	Λυα 10 2013	
KF SWILCH	Κασ	338965/002	Feb. 19, 2013	Aug. 19, 2013	
RF Cable	N/A	N/A/	Feb. 19, 2013	Aug. 19, 2013	
KF Cable	IN/A	C0052 ~ 56	Feb. 19, 2013	Aug. 19, 2013	
Test Software	Audix	e3/	NCR	NCD	
Test Software	Audix	Ver. 5.2004-2-19k	NOR	NCR	
TR5	ETS	TR5/	NCR	NCR	
shielded room	LINDGREN	15353-F	NOR	NOR	

#### Note:

- 1. The calibrations are traceable to NML/ROC.
- NCR: No Calibration Required. 2.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## **Measurement Uncertainty**

The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than  $U_{cispr}$  in table 1 of CISPR 16-4-2.

Equipment	Model Number	Uncertainty Value
LISN	ESH2-Z5	3.1dB
2.511	ENV 4200	2.7dB

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

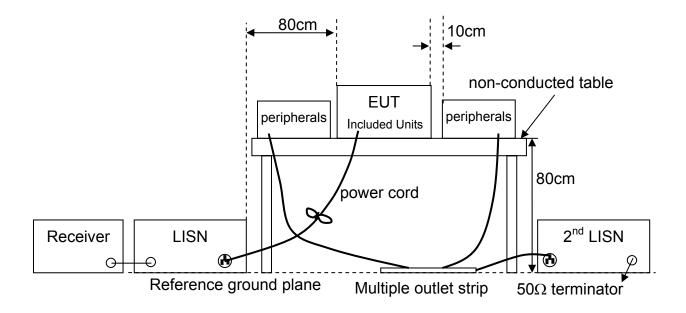
#### 2.3 Test Procedures

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters above the reference ground plane and 0.4 meters from the conducting wall of the shielded room. Also if the EUT is floor-standing equipment, it was placed on a non-conducted support with a height up to 0.15 meters above the reference ground plane.
- c. Connect the EUT's power source lines to the appropriate power mains / peripherals through the LISN.
- d. All the other peripherals are connected to the 2<sup>nd</sup> LISN, if any.
- e. The LISN was placed 0.8 meters from the EUT and at least 0.8 meters from other units and other metal planes.
- f. Measure the conducted emissions on each power line (Neutral Line and Line 1 Hot side) of the EUT's power source by using the test receiver connected to the coupling RF output port of LISN.
- g. Rapidly scan the signal from 150kHz to 30MHz by using the receiver through the Maximum-Peak detector to determine those frequencies associated with higher emission levels for each measured line.
- h. Then measure the maximum level of conducted disturbance for each frequency found from step g. by using the receiver through the Quasi-Peak and Average detectors per CISPR 16-1.
- i. Record the level for each frequency and compare with the required limit.
- j. If the peak emission level is lower than the specified Average limit, then the emission values presented will be the peak value only. Otherwise, accurate Q.P. or Average values will be measured and presented.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 2.4 Test Configurations



## 2.5 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

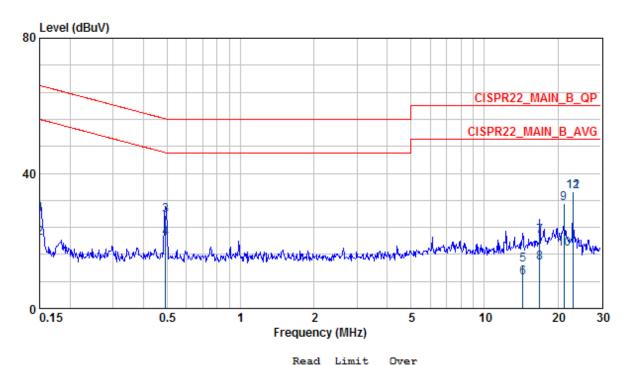
#### 2.6 Test Results

**Test Mode :** Normal **Test Voltage :** 230V/50Hz

**Tester**: Rack **Temperature**: 26°C

Humidity: 61%RH Frequency Range: 150kHz~30MHz

IF Bandwidth: 9kHz Phase: Line



				Kead	Limit	over		
	Freq	Level	Factor	Level	Line	Limit	Pol/Phase	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB		
1	0.150	27.74	0.28	27.46	66.00	-38.26	LINE	QP
2	0.150	20.70	0.28	20.42	56.00	-35.30	LINE	AVERAGE
3	0.493	27.63	0.31	27.32	56.11	-28.47	LINE	QP
4	0.493	20.79	0.31	20.48	46.11	-25.31	LINE	AVERAGE
5	14.364	12.94	0.69	12.25	60.00	-47.06	LINE	QP
6	14.364	9.03	0.69	8.34	50.00	-40.97	LINE	AVERAGE
7	16.836	21.35	0.72	20.63	60.00	-38.65	LINE	QP
8	16.836	13.50	0.72	12.78	50.00	-36.50	LINE	AVERAGE
9	21.175	31.17	0.67	30.50	60.00	-28.83	LINE	QP
10	21.175	17.47	0.67	16.80	50.00	-32.53	LINE	AVERAGE
11	22.998	34.48	0.56	33.92	60.00	-25.52	LINE	QP
12 @	22.998	34.47	0.56	33.91	50.00	-15.53	LINE	AVERAGE

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

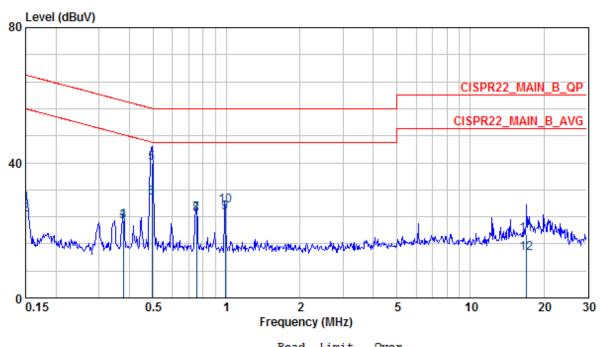
CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

**Tester**: Rack **Temperature**: 26°C

Humidity: 61%RH Frequency Range: 150kHz~30MHz

IF Bandwidth: 9kHz Phase: Neutral



				Kead	Limit	uver		
	Freq	Level	Factor	Level	Line	Limit	Pol/Phase	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB		
1	0.150	27.92	0.04	27.88	66.00	-38.08	NEUTRAL	QP
2	0.150	24.74	0.04	24.70	56.00	-31.26	NEUTRAL	AVERAGE
3	0.377	22.65	0.03	22.62	58.34	-35.69	NEUTRAL	QP
4	0.377	22.72	0.03	22.69	48.34	-25.62	NEUTRAL	AVERAGE
5	0.494	39.94	0.04	39.90	56.10	-16.16	NEUTRAL	QP
6	0.494	29.47	0.04	29.43	46.10	-16.63	NEUTRAL	AVERAGE
7	0.755	24.80	0.06	24.74	46.00	-21.20	NEUTRAL	AVERAGE
8	0.755	24.55	0.06	24.49	56.00	-31.45	NEUTRAL	QP
9	0.988	25.10	0.05	25.05	46.00	-20.90	NEUTRAL	AVERAGE
10	0.988	27.13	0.05	27.08	56.00	-28.87	NEUTRAL	QP
11	17.012	18.72	0.23	18.49	60.00	-41.28	NEUTRAL	QP
12	17.012	13.18	0.23	12.95	50.00	-36.82	NEUTRAL	AVERAGE

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 3. Disturbance Power Measurement

Test Result : PASS

## 3.1 Limits for Emission Measurement

## **☑** Disturbance power limits

Frequency	Quasi-peak	Average
(MHz)	(dBpW)	(dBpW)
30 to 300	45 – 55	35 – 45
Note 1- The limit increases linearl	y with the frequency in the range 3	30 MHz to 300MHz.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 3.2 Test Instruments

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Wandacturer	Serial No.	<b>Calibration Date</b>	Due Date	
Test Receiver	R&S	ESCS 30/	Jan. 14, 2013	Jan. 14, 2014	
lest Receiver	Κασ	836858/021	Jan. 14, 2013		
Absorbing Clamp	R&S	MDS21/	June. 14, 2012	luno 14 2012	
Absorbing Clamp	Κασ	833711/029	Julie. 14, 2012	June. 14, 2013	
DE Curitob	Doc	RSU28/	Fab 10 2012	Aug. 10, 2012	
RF Switch	R&S	338965/002	Feb. 19, 2013	Aug. 19, 2013	
DE Cabla	NI/A	N/A/	Fab 10 2012	Aug. 10, 2012	
RF Cable	N/A	C0052 ~ 56	Feb. 19, 2013	Aug. 19, 2013	
Test Software	Audiy	e3/	NCD	NCR	
Test Software	Audix	Ver. 5.2004-2-19k	NCR		
TR5	ETS	TR5/	NCD	NCD	
shielded room	LINDGREN	15353-F	NCR	NCR	

#### Note:

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR: No Calibration Required.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## **Measurement Uncertainty**

The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than  $U_{cispr}$  in table 1 of CISPR 16-4-2.

Equipment	Model Number	Uncertainty Value
Clamp	MDS21	3.5 dB

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

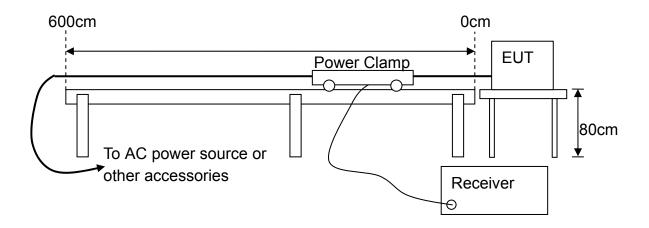
#### 3.3 Test Procedures

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters above the reference ground plane and 0.4 meters from the conducting wall of the shielded room. Also if the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters above the reference ground plane.
- c. Connect each of the EUT's terminal line to the appropriate auxiliaries / accessories thorough the absorbing clamp.
- d. Measure the emissions on each terminal line of the EUT by using the test receiver connected to the RF output port of absorbing clamp which is fixed at the 0cm position.
- e. Rapidly scan the signal from 30MHz to 300MHz by using the receiver through the Maximum-Peak detector to determine those frequencies associated with higher emission levels for each terminal line.
- f. Then measure each frequency found from step c by using the receiver through the Quasi-Peak and Average detectors per CISPR 16-1.with moving the absorbing clamp from the position 0cm to 500cm to determine the maximum level.
- g. Record the level for each frequency and compare with the required limit.
- h. If the peak emission level is lower than the specified Average limit, then the emission values presented will be the peak value only. Otherwise, accurate Q.P. or Average values will be measured and presented.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 3.4 Test Configurations



## 3.5 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

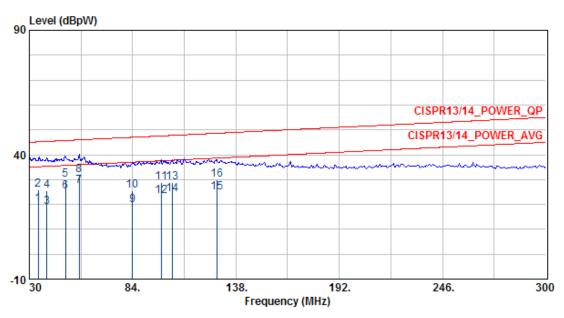
#### 3.6 Test Results

### Measurement at power line

**Test Mode :** Normal **Test Voltage :** 230V/50Hz

**Tester**: Der-Jan Ken **Temperature**: 23°C

Humidity: 43%RH Frequency Range: 30MHz~300MHz



					Read	Limit	Over	Ant		
		Freq	Level	Factor	Level	Line	Limit	Pos	Pol/Phase	Remark
	_									
		MHz	dBpW	dB	dBpW	dBpW	dB	cm		
1		34.662	19.89	26.07	-6.18	35.17	-15.28	160	LINE	AVERAGE
2		34.662	26.05	26.07	-0.02	45.17	-19.12	160	LINE	QP
3		39.186	19.10	25.92	-6.82	35.34	-16.24	130	LINE	AVERAGE
4		39.186	25.59	25.92	-0.33	45.34	-19.75	130	LINE	QP
5		48.981	30.10	25.80	4.30	45.70	-15.60	110	LINE	QP
6		48.981	25.29	25.80	-0.51	35.70	-10.41	110	LINE	AVERAGE
7	@	56.141	27.54	25.56	1.98	35.97	-8.43	90	LINE	AVERAGE
8		56.141	31.83	25.56	6.27	45.97	-14.14	90	LINE	QP
9		84.024	19.84	24.00	-4.16	37.00	-17.16	190	LINE	AVERAGE
10		84.024	25.53	24.00	1.53	47.00	-21.47	190	LINE	QP
11		99.094	28.89	24.51	4.38	47.56	-18.67	25	LINE	QP
12		99.094	23.45	24.51	-1.06	37.56	-14.11	25	LINE	AVERAGE
13		104.747	28.82	24.56	4.26	47.77	-18.95	50	LINE	QP
14		104.747	23.97	24.56	-0.59	37.77	-13.80	50	LINE	AVERAGE
15		128.108	24.71	24.28	0.43	38.63	-13.93	10	LINE	AVERAGE
16		128.108	30.01	24.28	5.73	48.63	-18.63	10	LINE	QP

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of absorbing clamp.
- 3. P.K., Q.P. and AV. are abbreviation of peak, quasi-peak and average respectively.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

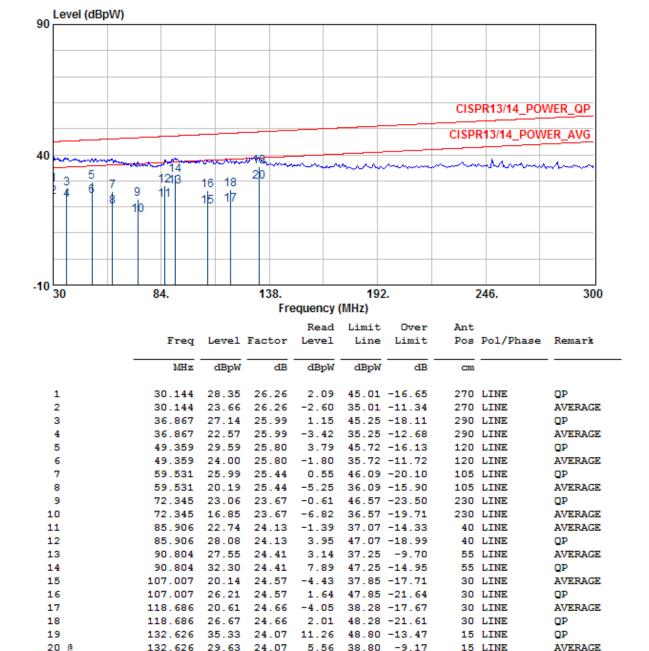
#### Measurement at connecting terminals

Test Mode : Normal Test Voltage : 230V/50Hz

**Tester**: Der-Jan Ken **Temperature**: 23°C

Humidity: 43%RH Frequency Range: 30MHz~300MHz

IF Bandwidth: 120kHz Cable: Source 1 line in



#### Note:

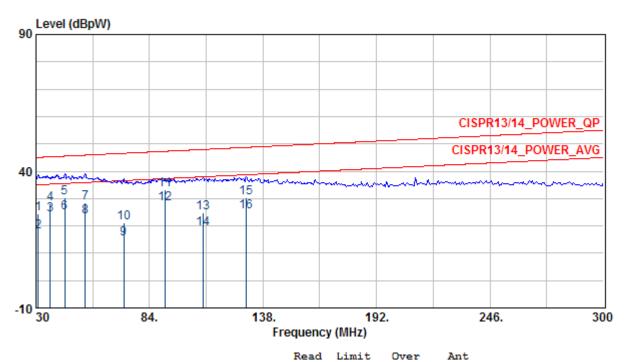
- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of absorbing clamp.
- 3. P.K., Q.P. and AV. are abbreviation of peak, quasi-peak and average respectively.
- 4. If the limit for the measurement with the average detector is met when using a receiver with

a quasi-peak detector, the EUT shall be deemed to meet both limits.

**Tester**: Der-Jan Ken **Temperature**: 23°C

Humidity: 43%RH Frequency Range: 30MHz~300MHz

IF Bandwidth: 120kHz Cable : Source 1 out



	Freq	Level	Factor	Level	Line	Limit	Pos	Pol/Phase	Remark
	MHz	dBpW	dB	dBpW	dBpW	dB	cm		
1	30.983	24.60	26.23	-1.63	45.04	-20.44	0	LINE	QP
2	30.983	17.79	26.23	-8.44	35.04	-17.25	0	LINE	AVERAGE
3	36.868	24.11	25.99	-1.88	35.25	-11.14	170	LINE	AVERAGE
4	36.868	28.07	25.99	2.08	45.25	-17.18	170	LINE	QP
5	43.715	30.26	25.85	4.41	45.51	-15.25	130	LINE	QP
6	43.715	24.88	25.85	-0.97	35.51	-10.63	130	LINE	AVERAGE
7	53.512	28.38	25.65	2.73	45.87	-17.49	120	LINE	QP
8	53.512	23.32	25.65	-2.33	35.87	-12.55	120	LINE	AVERAGE
9	71.799	15.38	23.67	-8.29	36.55	-21.17	0	LINE	AVERAGE
10	71.799	21.27	23.67	-2.40	46.55	-25.28	0	LINE	QP
11	91.197	33.30	24.41	8.89	47.27	-13.96	60	LINE	QP
12	91.197	28.10	24.41	3.69	37.27	-9.16	60	LINE	AVERAGE
13	109.659	24.74	24.59	0.15	47.95	-23.21	120	LINE	QP
14	109.659	18.82	24.59	-5.77	37.95	-19.13	120	LINE	AVERAGE
15	130.006	30.13	24.19	5.94	48.70	-18.58	235	LINE	QP
16	130.006	25.04	24.19	0.85	38.70	-13.67	235	LINE	AVERAGE

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of absorbing clamp.
- 3. P.K., Q.P. and AV. are abbreviation of peak, quasi-peak and average respectively.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

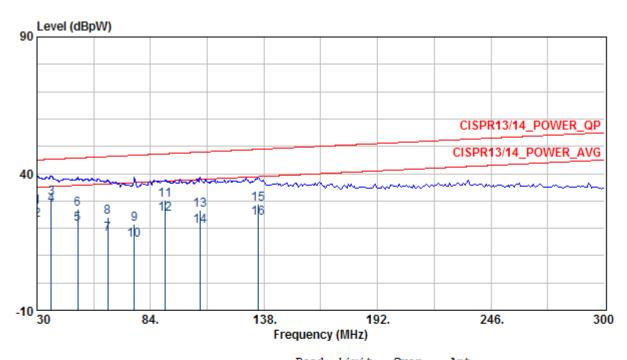
CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

**Tester**: Der-Jan Ken **Temperature**: 23°C

Humidity: 43%RH Frequency Range: 30MHz~300MHz

IF Bandwidth: 120kHz Cable : Zone 1 out



				Read	Limit	Over	Ant		
	Freq	Level	Factor	Level	Line	Limit	Pos	Pol/Phase	Remark
	MHz	dBpW	dB	dBpW	dBpW	dB	cm		
1	30.145	27.66	26.26	1.40	45.01	-17.34	260	LINE	QP
2	30.145	23.11	26.26	-3.15	35.01	-11.89	260	LINE	AVERAGE
3	36.868	30.90	25.99	4.91	45.25	-14.35	160	LINE	QP
4 @	36.868	28.38	25.99	2.39	35.25	-6.87	160	LINE	AVERAGE
5	49.363	21.35	25.80	-4.45	35.72	-14.37	60	LINE	AVERAGE
6	49.363	27.15	25.80	1.35	45.72	-18.57	60	LINE	QP
7	63.697	17.92	24.74	-6.82	36.25	-18.33	100	LINE	AVERAGE
8	63.697	23.93	24.74	-0.81	46.25	-22.32	100	LINE	QP
9	76.405	21.65	23.70	-2.05	46.72	-25.07	100	LINE	QP
10	76.405	15.56	23.70	-8.14	36.72	-21.16	100	LINE	AVERAGE
11	91.190	30.43	24.41	6.02	47.27	-16.83	50	LINE	QP
12	91.190	25.06	24.41	0.65	37.27	-12.20	50	LINE	AVERAGE
13	107.390	26.46	24.58	1.88	47.87	-21.41	160	LINE	QP
14	107.390	20.84	24.58	-3.74	37.87	-17.03	160	LINE	AVERAGE
15	135.274	28.97	23.95	5.02	48.90	-19.93	45	LINE	QP
16	135.274	23.54	23.95	-0.41	38.90	-15.36	45	LINE	AVERAGE

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of absorbing clamp.
- 3. P.K., Q.P. and AV. are abbreviation of peak, quasi-peak and average respectively.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

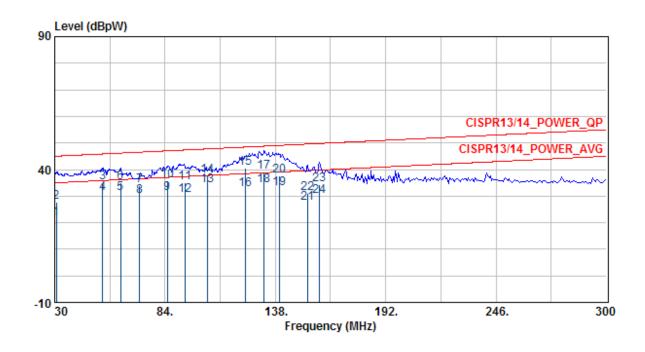
CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

**Tester**: Der-Jan Ken **Temperature**: 23°C

Humidity: 43%RH Frequency Range: 30MHz~300MHz

**IF Bandwidth**: 120kHz **Cable**: Zone 1 out AMP speaker



11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

	Freq	Level	Factor	Read Level	Limit Line	Over Limit	Ant Pos	Pol/Phase	Remark
	MHz	dBpW	dB	dBpW	dBpW	dB	cm		
1	30.896	21.43	26.23	-4.80	35.03	-13.60	260	LINE	AVERAGE
2	30.896	27.79	26.23	1.56	45.03	-17.24	260	LINE	QP
3	53.504	34.98	25.65	9.33	45.87	-10.89	0	LINE	QP
4	53.504	31.01	25.65	5.36	35.87	-4.86	0	LINE	AVERAGE
5	62.169	31.05	25.02	6.03	36.19	-5.14	130	LINE	AVERAGE
6	62.169	35.04	25.02	10.02	46.19	-11.15	130	LINE	QP
7	71.589	33.94	23.67	10.27	46.54	-12.60	80	LINE	QP
8	71.589	30.03	23.67	6.36	36.54	-6.51	80	LINE	AVERAGE
9	85.150	31.13	24.08	7.05	37.04	-5.91	0	LINE	AVERAGE
10	85.150	35.75	24.08	11.67	47.04	-11.29	0	LINE	QP
11	93.817	34.91	24.45	10.46	47.36	-12.46	0	LINE	QP
12	93.817	30.44	24.45	5.99	37.36	-6.93	0	LINE	AVERAGE
13 @	104.745	33.79	24.56	9.23	37.77	-3.98	60	LINE	AVERAGE
14	104.745	37.54	24.56	12.98	47.77	-10.23	60	LINE	QP
15	123.206	40.52	24.51	16.01	48.45	-7.93	20	LINE	QP
16	123.206	32.55	24.51	8.04	38.45	-5.90	0	LINE	AVERAGE
17	132.250	38.96	24.09	14.87	48.79	-9.83	5	LINE	QP
18	132.250	34.10	24.09	10.01	38.79	-4.69	5	LINE	AVERAGE
19	139.784	32.71	23.76	8.95	39.07	-6.36	0	LINE	AVERAGE
20	139.784	37.48	23.76	13.72	49.07	-11.59	0	LINE	QP
21	153.611	27.45	23.28	4.17	39.58	-12.13	0	LINE	AVERAGE
22	153.611	31.14	23.28	7.86	49.58	-18.44	0	LINE	QP
23	159.755	34.49	23.09	11.40	49.81	-15.32	0	LINE	QP
24	159.755	29.76	23.09	6.67	39.81	-10.05	0	LINE	AVERAGE

#### Note:

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of absorbing clamp.
- 3. P.K., Q.P. and AV. are abbreviation of peak, quasi-peak and average respectively.
- 4. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the EUT shall be deemed to meet both limits.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 4. Harmonic Current Emission Measurement

Test Result : PASS

#### 4.1 Limits for Emission Measurement

☑ Limits for Class A equipment

Harmonic order (n)	Maximum permissible	Harmonic order (n)	Maximum permissible
Odd harmonics	harmonic current (A)	Even Harmonics	harmonic current (A)
3	2.30	2	1.08
5	1.14	4	0.43
7	0.77	6	0.3
9	0.40	8 ≦ n ≦40	0.23 8/n
11	0.33		
13	0.21		
$15 \leq n \leq 39$	0.15 15/n		

## ☐ Limits for Class B equipment

It shall not exceed the vales give in calss A multiplied by a factor of 1.5.

☐ Limits for Class C equipment

Harmonic order (n)	Maximum permissible harmonic current expressed as a percentage of the input current at the fundamental frequency %			
2	2			
3	$30$ · $\lambda$ ( $\lambda$ is the circuit power factor)			
5	10			
7	7			
9	5			
11 ≤ n ≤ 39	3			
(odd harmonics only)				

☐ Limits for Class D equipment

Harmonic order (n)	Maximum permissible harmonic	Maximum permissible harmonic	
Trannonic order (ii)	current per watt (mA/W)	current (A)	
3	3.4	2.30	
5	1.9	1.14	
7	1.0	0.77	
9	0.5	0.40	
11	0.35	0.33	
13 ≤ n ≤ 39	3.85/n	See class A	
(odd harmonics only)			

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### **Test Instruments** 4.2

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Manufacturer	Serial No.	<b>Calibration Date</b>	Due Date	
Power Source		5001ix-208/	Oct. 17, 2012	Oct. 17, 2013	
Power Source	California	56619	OCI. 17, 2012		
Power Analyzer	Instrument	PACS-1/	Oct. 17, 2012	Oct. 17, 2013	
Powei Analyzei		72398	OCI. 17, 2012		
Test Software	C.I.	CTS 3.0/	NCR	NCR	
Test Software		Ver. 3.2.0.18	NCR		
TR7	ETS.	TR7/	NCR	NCR	
shielded room	LINDGREN	15353-D	NOR		

#### Note:

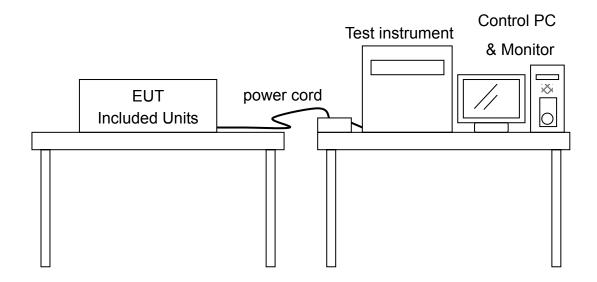
- The calibrations are traceable to NML/ROC.
- NCR: No Calibration Required. 2.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### **Test Procedures** 4.3

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters in the shielded room.
- c. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters in the shielded room.
- d. Decide the classification of the EUT as following:
  - Class A: balanced three-phase equipment
    - household appliances, excluding equipment identified as class D
    - tools, excluding portable tools
    - dimmers for incandescent lamps
    - audio equipment
    - equipments not specified in one of the three other classes
  - Class B: portable tools
    - arc welding equipment which is not professional equipment.
  - Class C: lighting equipment
  - Class D: Equipment specified power less than or equal to 600W of the following types
    - personal computers and personal computer monitors
    - television receivers
- e. Connects the EUT's power source to the mains power supplied by the test instrument. Turn on the EUT.
- f. Operating the EUT as required and measuring the harmonic current emissions on the current carrying lines of EUT's power source.

# 4.4 Test Configurations



## 4.5 Photographs of the Test Configurations

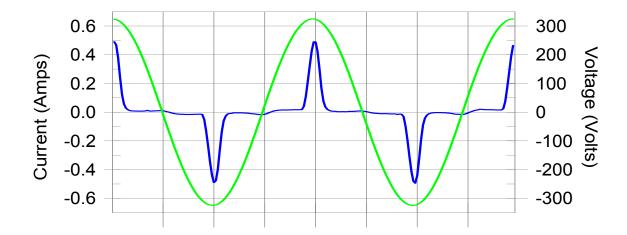
Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 4.6 Test Results

Test Mode : Normal
Tester : Kent
Temperature : 26°C
Humidity : 44%RH

TEST FREQ	50
TEST VOLTS	230
TEST TIME	10 Minutes
MAX WATTS	20.7 W



The EUT power level is below 75.0 Watts and therefore has no defined limits.

#### **Test Raw Data:**

100111	aw Data.						
Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.001	1.080	0.1	0.001	1.620	0.08	N/L
3	0.073	2.300	3.2	0.073	3.450	2.11	N/L
4	0.002	0.430	0.4	0.002	0.645	0.25	N/L
5	0.065	1.140	5.7	0.065	1.710	3.81	N/L
6	0.000	0.300	0.0	0.000	0.450	0.10	N/L
7	0.049	0.770	6.4	0.049	1.155	4.25	N/L
8	0.001	0.230	0.3	0.001	0.345	0.23	N/L
9	0.035	0.400	8.8	0.035	0.600	5.89	N/L
10	0.000	0.184	0.0	0.000	0.276	0.16	N/L
11	0.022	0.330	6.8	0.022	0.495	4.52	N/L
12	0.000	0.153	0.2	0.001	0.230	0.23	N/L
13	0.012	0.210	5.9	0.012	0.315	3.91	N/L
14	0.000	0.131	0.0	0.000	0.197	0.14	N/L
15	0.005	0.150	3.7	0.005	0.225	2.44	N/L
16	0.000	0.115	0.0	0.000	0.173	0.14	N/L
17	0.002	0.132	1.5	0.002	0.199	1.03	N/L
18	0.000	0.102	0.0	0.000	0.153	0.17	N/L
19	0.002	0.118	1.8	0.002	0.178	1.18	N/L
20	0.000	0.092	0.0	0.000	0.138	0.16	N/L
21	0.002	0.107	2.1	0.002	0.161	1.43	N/L
22	0.000	0.084	0.0	0.000	0.125	0.13	N/L
23	0.002	0.098	1.8	0.002	0.147	1.21	N/L
24	0.000	0.077	0.0	0.000	0.115	0.14	N/L
25	0.001	0.090	1.2	0.001	0.135	0.78	N/L
26	0.000	0.071	0.0	0.000	0.106	0.12	N/L
27	0.000	0.083	0.0	0.000	0.125	0.29	N/L
28	0.000	0.066	0.0	0.000	0.099	0.17	N/L
29	0.000	0.078	0.0	0.000	0.116	0.33	N/L
30	0.000	0.061	0.0	0.000	0.092	0.22	N/L
31	0.001	0.073	0.8	0.001	0.109	0.51	N/L
32	0.000	0.058	0.0	0.000	0.086	0.18	N/L
33	0.001	0.068	0.8	0.001	0.102	0.53	N/L
34	0.000	0.054	0.0	0.000	0.081	0.15	N/L
35	0.000	0.064	0.0	0.000	0.096	0.43	N/L
36	0.000	0.051	0.0	0.000	0.077	0.16	N/L
37	0.000	0.061	0.0	0.000	0.091	0.29	N/L
38	0.000	0.048	0.0	0.000	0.073	0.13	N/L
39	0.000	0.058	0.0	0.000	0.087	0.20	N/L
40	0.000	0.046	0.0	0.000	0.069	0.16	N/L

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 5. Voltage Fluctuations and Flickers Emission Measurement

Test Result : PASS

#### 5.1 Limits for Emission Measurement

- the short-term flicker indicator, P<sub>st</sub>, shall not be greater than 1.0;
- the long-term flicker indicator, P<sub>lt</sub>, shall not be greater than 0.65;
- the relative steady-state voltage change, d<sub>c</sub>, shall not exceed 3.3%;
- the voltage change with time, d(t), during a voltage change shall not exceed 3.3% for more than 500ms.
- the maximum relative voltage change, d<sub>max</sub>, shall not exceed
  - ☑ a) 4% without additional conditions;
  - □ b) 6% for equipment which is switched manually
  - □ c) 7% for equipment which is attended whilst in use

#### 5.2 Test Instruments

Test Site and	Manufacturer	Model No./	Last	Calibration
Equipment	Wanulacturer	Serial No.	<b>Calibration Date</b>	Due Date
Power Source	California Instrument	5001ix-208/ 56619	Oct. 17, 2012	Oct. 17, 2013
Power Analyzer		PACS-1/ 72398	Oct. 17, 2012	Oct. 17, 2013
Test Software	C.I.	CTS 3.0/ Ver. 3.2.0.18	NCR	NCR
TR7 shielded room	ETS. LINDGREN	TR7/ 15353-D	NCR	NCR

#### Note:

1. The calibrations are traceable to NML/ROC.

2. NCR : No Calibration Required.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

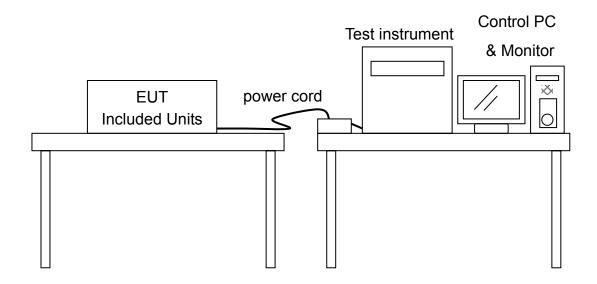
#### 5.3 Test Procedures

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters in the shielded room.
- c. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters in the shielded room.
- d. Decide the type of EUT to define the  $d_{\text{max}}$  limit and its corresponding test methods described in the relative standard.
- e. Maintain the supply voltage to be  $\pm 2\%$  of the EUT's rated voltage and also the frequency to be 50Hz  $\pm 0.5\%$ .
- f. Verify the total harmonic distortion of the supply voltage to be less than 3%.
- g. Connects the EUT's power source to the mains power supplied by the test instrument.
- h. Operating the EUT as required and measuring the voltage fluctuation and flickers of EUT's power source.
- i. Verify the fluctuations of the test supply voltage to be less than 0.4 before and after the test.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 5.4 Test Configurations



## 5.5 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Page: 43 / 97

#### **5.6 Test Results**

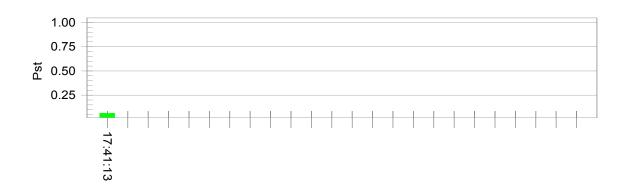
**Test Mode** Normal

**Tester** Kent

26°C **Temperature** 

**Humidity** 44%RH

TEST FREQ	50			
TEST VOLTS	230	230		
TEST TIME	10 Minutes	10 Minutes		
	EUT Data	Limit		
d(t)>3.3% (ms)	0	500		
d <sub>c</sub> (%)	0	3.3		
d <sub>max</sub> (%)	0	4		
P <sub>st</sub> max	0.064	1		
P <sub>lt</sub> max	0.028	0.65		



## 6. Immunity Against RFI Voltage(S2a)

Test Result : PASS

## **6.1** Limits for Immunity Measurement

Limits of immunity to RF voltages of mains, loudspeaker and headphone terminals

Frequency (MHz)	<b>Level</b> dB( μV) (e.m.f.)		
0.15 to 30	130		
30 to 100	120		
100 to 150	120 – 110 <sup>a</sup>		
a Decreasing linearly with the logarithm of the frequency.			

Limits of immunity to RF voltages of audio input and output terminals (except loudspeaker and headphone terminals)

Frequency (MHz)	<b>Level</b> dB( μ V) (e.m.f.)
0.15 to 1.6	80 – 90 <sup>a</sup>
1.6 to 20	90 – 120 <sup>a</sup>
20 to 100	120
100 to 150	120 – 110 <sup>b</sup>

a Increasing linearly with the logarithm of the frequency.
b Decreasing linearly with the logarithm of the frequency.

**Test Voltage** : 230V/50Hz

Tester : Jacky Kao

Ambient Temperature : 25°C

Relative Humidity : 45%

**Atmospheric Pressure** : 1012mbar

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 6.2 **Description of Performance Criteria**

#### Performance criterion A

The equipment shall continue to operate as intended during the test. No change of actual operating state (for example change of channel) is allowed as a result of the application of the test. Multifunction equipment shall for each function meet the relevant requirements. Evaluation is carried out for audio and video functions. The equipment is supposed to operate as intended if the criteria of "Evaluation of audio quality" and/or "Evaluation of picture quality" are fulfilled.

#### Performance criterion B

The equipment shall continue to operate as intended after the test. No loss of function is allowed after the test when the apparatus is used as intended, but failures which are recovered automatically but which cause temporary delay in processing, are permissible. No change of actual operating state for example change of channel or stored data and settings is allowed as a result of the application of the test. During the test, degradation of performance is allowed.

CENTRAL RESEARCH TECHNOLOGY CO.

FAX.: 886-2-25984546

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. TEL.: 886-2-25984542

Page: 45 / 97

## 6.3 Test Instruments

Test Site and	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date
Equipment			Calibration Date	Due Date
Test Receiver	R&S	ESCI/	March 1, 2013	March 1, 2014
		100316	,	,
Signal Generator	R&S	SML01/	Dec. 15, 2011	Dec. 15, 2013
		104230	200. 10, 2011	200. 10, 2010
Signal Generator	R&S	SML02/	Dec. 15, 2011	Dec. 15, 2013
Signal Generator	Nao	101519	Dec. 13, 2011	Dec. 13, 2013
Adia Analyman	000	UPL/	Dec 40 0044	D 40 0040
Audio Analyzer	R&S	101285	Dec. 16, 2011	Dec. 16, 2013
D 4 116	D.0.0	BSA 1515-25/	D 40 0044	D 40 0040
Power Amplifier	R&S	055966-5	Dec. 16, 2011	Dec. 16, 2013
TV Test		SFQ/		<b>5</b>
Transmitter	R&S	100565	Dec. 14, 2011	Dec. 14, 2013
TV Test		SFM/		Dec. 14, 2013
Transmitter	R&S	100182	Dec. 14, 2011	
TV Generator		SGSF/		
SECAM	R&S	100062	Dec. 19, 2011	Dec. 19, 2013
TV Generator		SGMF/		
NTSC	R&S	100043	Dec. 19, 2011	Dec. 19, 2013
TV Generator		SGPF/		
PAL	R&S	100160	Dec. 19, 2011	Dec. 19, 2013
MPEG2		100100		
Measurement	R&S	DVG/	Dec. 19, 2011	Dec. 19, 2013
	Ras	100403	Dec. 19, 2011	Dec. 19, 2013
Generator		NDVD/		
Power Meter	R&S	NRVD/	Dec. 3, 2012	Dec. 3, 2013
		837333/066		
RF Probe	R&S	URV5-Z4/	Oct. 18, 2012	Oct. 18, 2013
	1 13.0	100121	,	·
Test Software	R&S	T80-K1 V2.1	NCR	NCR
			_	_
TR20	ETS	TR20/	NCR	NCR
shielded room	LINDGREN	17873-2		

#### Note:

1. The calibrations are traceable to NML/ROC.

2. NCR: No Calibration Required.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

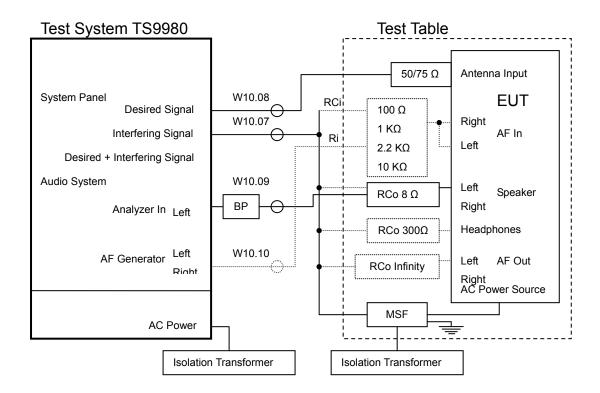
#### 6.4 Test Procedures

- a. Network RCi matches the RF disturbance source to the input impedance of the relevant audio terminal and a similar network RCo is used to match the output terminals.
- b. A mains stopfilter MSF is used to inject the unwanted signal at the mains terminal and acts as a stopfilter for unwanted signals from the mains network.
- c. The EUT is placed 0.1m above the center of a metal ground plane of dimensions 2m by 1m.
- d. The mains lead is bundled to a length less than 0.3m and connected to the mains stop filter MSF.
- e. The ground connection of the mains filter(MSF) is directly connected to the metal table.
- f. All unused input/output connections on the EUT are terminated with the proper resistance.
- g. The power supplied to the test system and to the mains filter (MSF) is attached to an isolation transformer.
- h. The 50ohm RF carrier signal is connected from the test system via a 50/75 ohm matching pad (RAM) to the EUT.
- i. The measurements are performed with test software T80-K1 Ver. 2.1.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 6.5 Test Configurations



## 6.6 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 6.7 Test Results

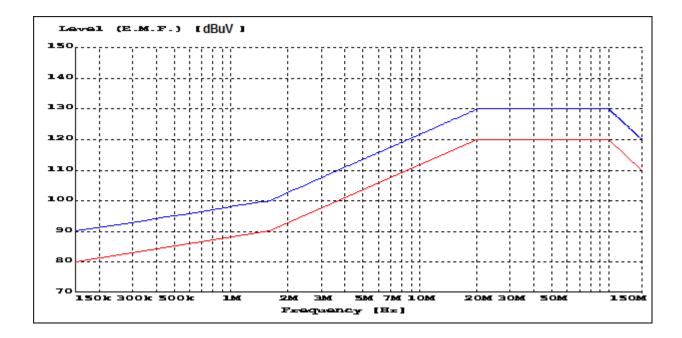
Test: Immunity Conducted Voltages S2a

Test Mode: Amplifier - Monitor: Speaker L

Operating Mode: AUX S/N: 74.8 dB

Frequency: - AF Level: 59.0 mW

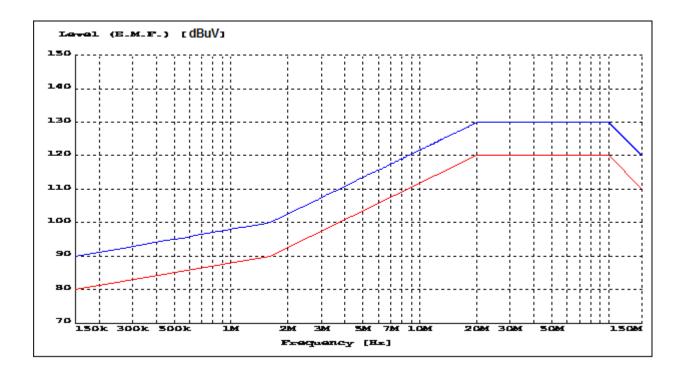
Interf. Signal: Source1 L



Operating Mode: AUX S/N: 74.8 dB

Frequency: - AF Level: 59.0 mW

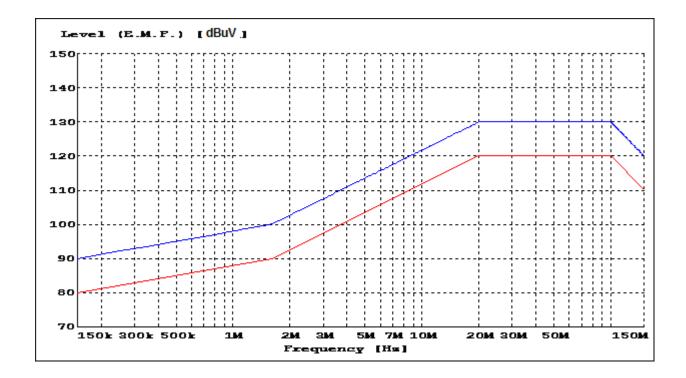
Interf. Signal: Source1 R



Operating Mode: AUX S/N: 73.8 dB

Frequency: - AF Level: 58.5 mW

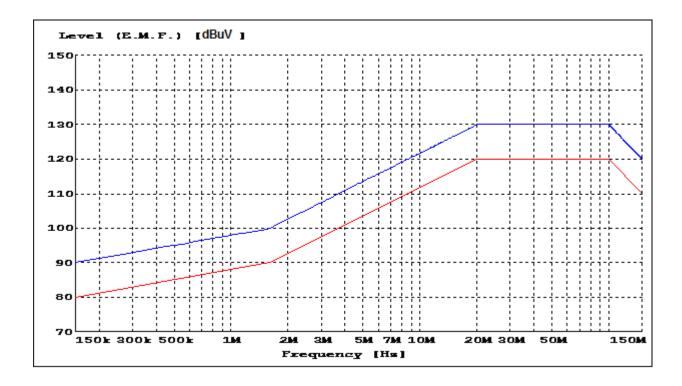
Interf. Signal: Loop Out L



Operating Mode: AUX S/N: 74.4 dB

Frequency: - AF Level: 60.1 mW

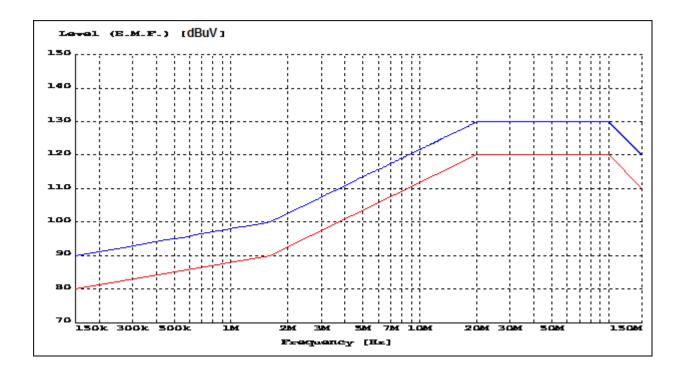
Interf. Signal: Loop Out R



Operating Mode: AUX S/N: 74.8 dB

Frequency: - AF Level: 59.0 mW

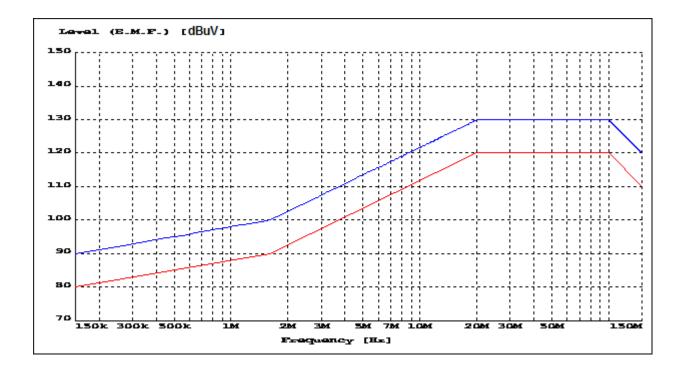
Interf. Signal: Pre Out L



Operating Mode: AUX S/N: 74.8 dB

Frequency: - AF Level: 59.0 mW

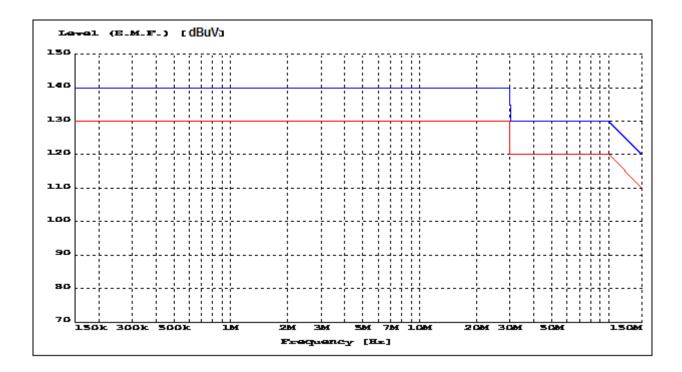
Interf. Signal: Pre Out R



Operating Mode: AUX S/N: 74.8 dB

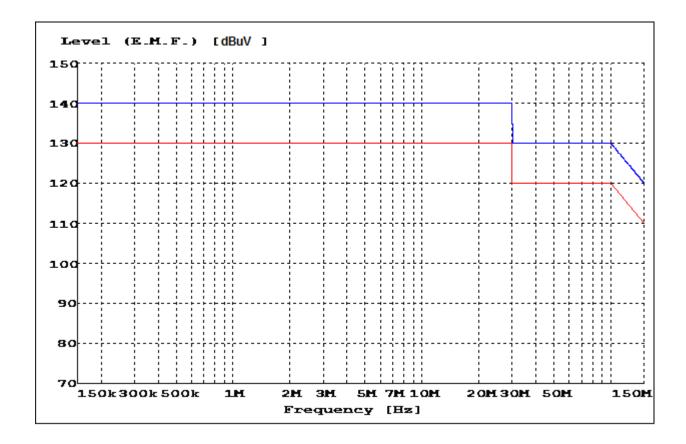
Frequency: - AF Level: 59.0 mW

Interf. Signal: Speaker L



Test Mode: Amplifier - Monitor: Speaker L
Operating Mode: AUX S/N: 74.8 dB
Frequency: - AF Level: 59.0 mW

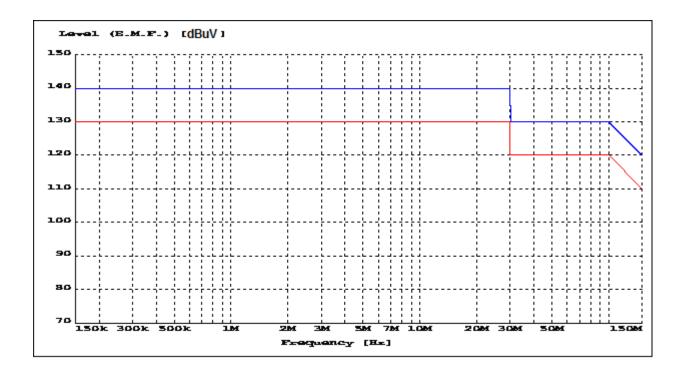
Interf. Signal: Speaker R



Operating Mode: AUX S/N: 74.8 dB

Frequency: - AF Level: 59.0 mW

Interf. Signal: Mains



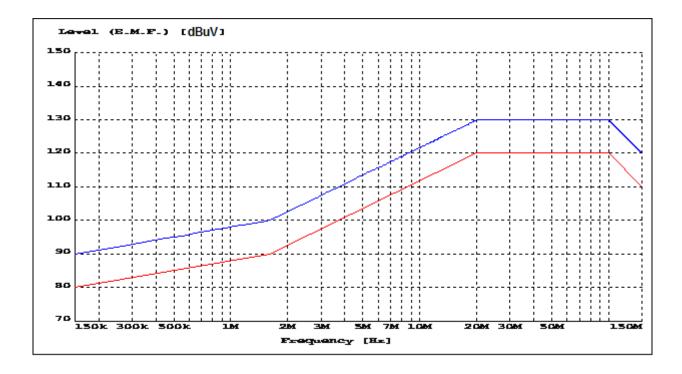
Test: Immunity Conducted Voltages S2a

Test Mode: Amplifier - Monitor: Speaker R

Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

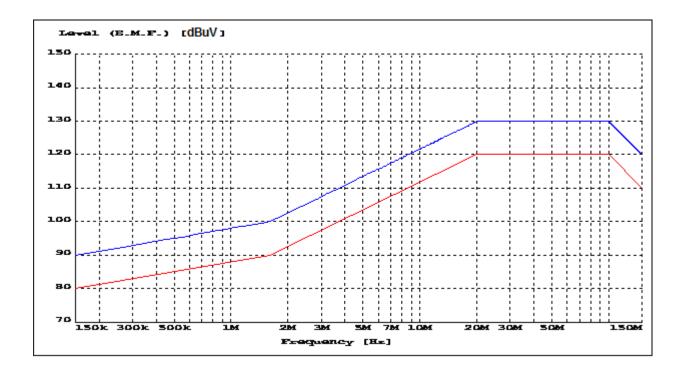
Interf. Signal: Source1 L



Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

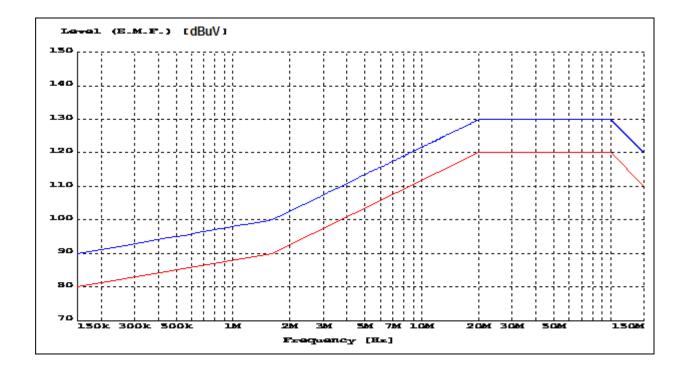
Interf. Signal: Source1 R



Operating Mode: AUX S/N: 74.4 dB

Frequency: - AF Level: 59.1 mW

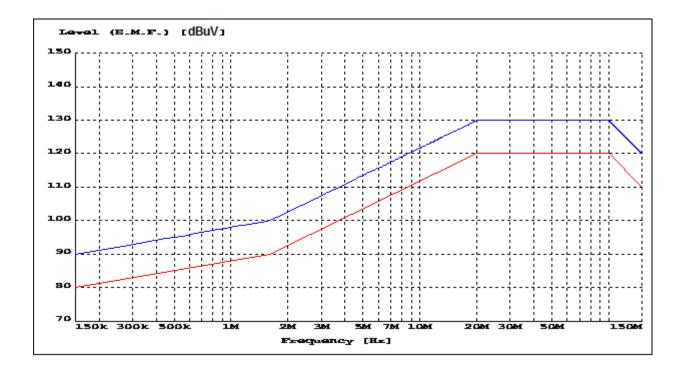
Interf. Signal: Loop Out L



Operating Mode: AUX S/N: 74.4 dB

Frequency: - AF Level: 59.1 mW

Interf. Signal: Loop Out R

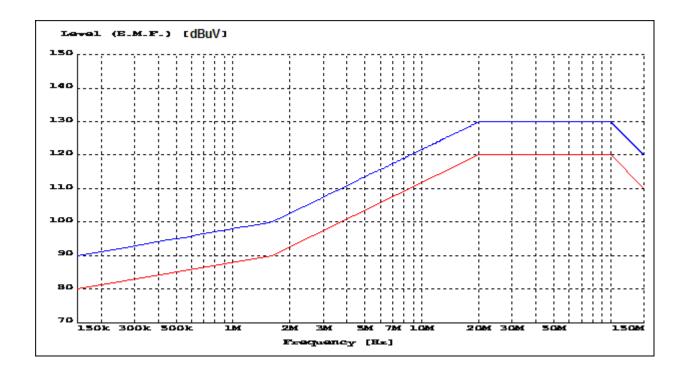


Test Mode: Amplifier - Monitor: Speaker R

Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

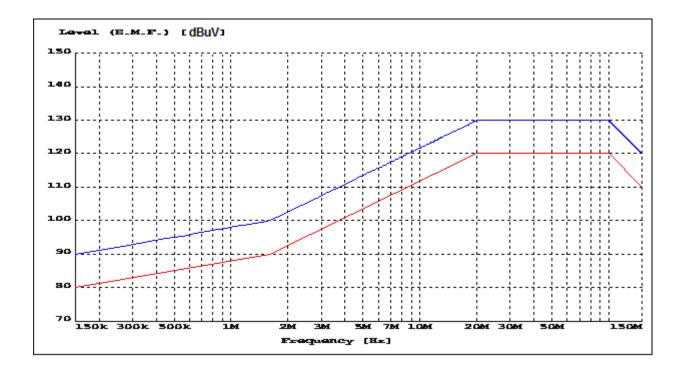
Interf. Signal: Pre Out L



Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

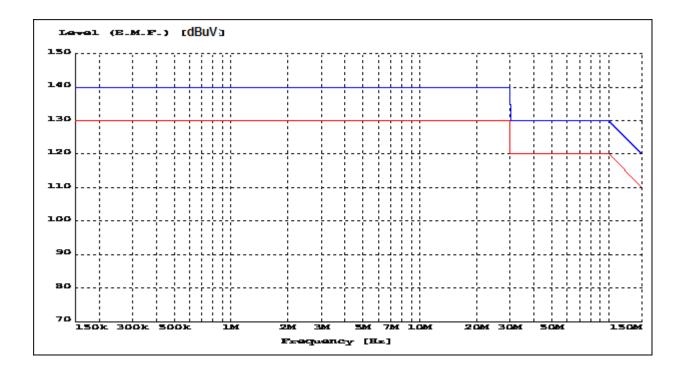
Interf. Signal: Pre Out R



Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

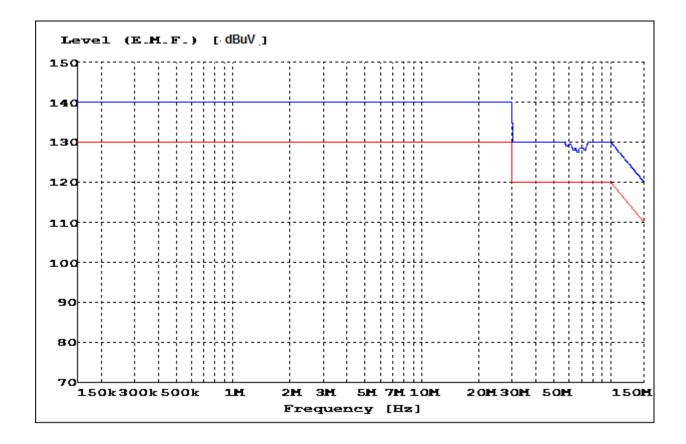
Interf. Signal: Speaker L



Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

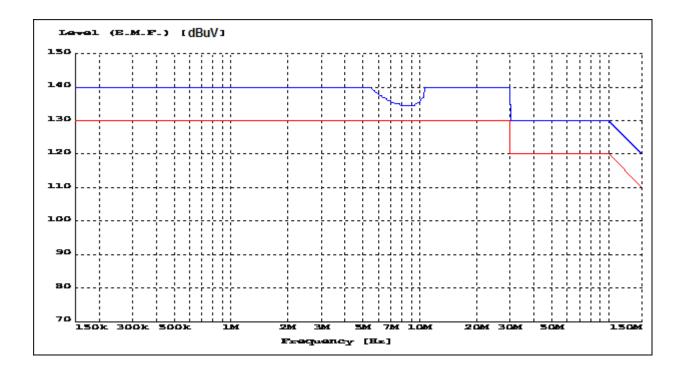
Interf. Signal: Speaker R



Operating Mode: AUX S/N: 73.3 dB

Frequency: - AF Level: 59.2 mW

Interf. Signal: Mains



## 7. Immunity Against Radiated RFI (S3)

## 7.1 Limits for Immunity Measurement

# Limits of immunity to ambient electromagnetic fields of equipment with audio or video functions

Frequency	<b>Level</b>
(MHz)	dB( μ V/m)
0.15 to 150	125

Test Voltage : 230V/50Hz

Tester : Jacky Kao

Ambient Temperature : 25°C

Relative Humidity : 50%

**Atmospheric Pressure** : 1015mbar

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 7.2 Description of Performance Criteria

#### Performance criterion A

The equipment shall continue to operate as intended during the test. No change of actual operating state (for example change of channel) is allowed as a result of the application of the test. Multifunction equipment shall for each function meet the relevant requirements. Evaluation is carried out for audio and video functions. The equipment is supposed to operate as intended if the criteria of "Evaluation of audio quality" and/or "Evaluation of picture quality" are fulfilled.

#### Performance criterion B

The equipment shall continue to operate as intended after the test. No loss of function is allowed after the test when the apparatus is used as intended, but failures which are recovered automatically but which cause temporary delay in processing, are permissible. No change of actual operating state for example change of channel or stored data and settings is allowed as a result of the application of the test. During the test, degradation of performance is allowed.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 7.3 Test Instruments

Test Site and Equipment	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date
Test Receiver	R&S	ESCI/ 100316	March 1, 2013	March 1, 2014
Signal Generator	R&S	SML01/ 104230	Dec. 15, 2011	Dec. 15, 2013
Signal Generator	R&S	SML02/ 101519	Dec. 15, 2011	Dec. 15, 2013
Audio Analyzer	R&S	UPL/ 101285	Dec. 16, 2011	Dec. 16, 2013
Power Amplifier	R&S	BSA 1515-25/ 055966-5	Dec. 16, 2011	Dec. 16, 2013
TV Test Transmitter	R&S	SFQ/ 100565	Dec. 14, 2011	Dec. 14, 2013
TV Test Transmitter	R&S	SFM/ 100182	Dec. 14, 2011	Dec. 14, 2013
TV Generator SECAM	R&S	SGSF/ 100062	Dec. 19, 2011	Dec. 19, 2013
TV Generator NTSC	R&S	SGMF/ 100043	Dec. 19, 2011	Dec. 19, 2013
TV Generator PAL	R&S	SGPF/ 100160	Dec. 19, 2011	Dec. 19, 2013
MPEG2 Measurement Generator	R&S	DVG/ 100403	Dec. 19, 2011	Dec. 19, 2013
Power Meter	R&S	NRVD/ 837333/066	Dec. 3, 2012	Dec. 3, 2013
RF Probe	R&S	URV5-Z4/ 100121	Oct. 18, 2012	Oct. 18, 2013
Test Software	R&S	T80-K1 V2.1	NCR	NCR
TR20 shielded room	ETS LINDGREN	TR20/ 17873-2	NCR	NCR

#### Note:

1. The calibrations are traceable to NML/ROC.

2. NCR: No Calibration Required.

CENTRAL RESEARCH TECHNOLOGY CO.

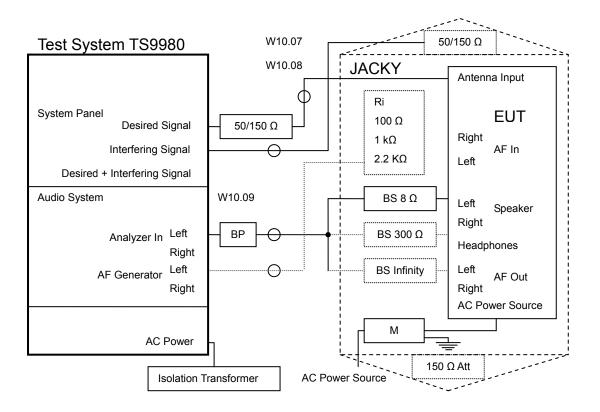
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 7.4 Test Procedures

- a. The EUT is placed on a non-metallic support, 0.1m high, in the center of the stripline.
- b. The wanted signal is fed to all input terminals respectively. The unwanted signal is fed to a matching network of the stripline.
- c. The ground connection of the mains filter(M) is directly connected to the JACKY.
- d. All unused input/output connections on the EUT are terminated and shielded with the proper resistance.
- e. The power supply to the mains of the EUT is attached to the mains filter(M).
- f. The measurements were performed with test software T80-K1 Ver. 2.1.

CENTRAL RESEARCH TECHNOLOGY CO. 11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

## 7.5 Test Configurations



## 7.6 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 7.7 Test Results

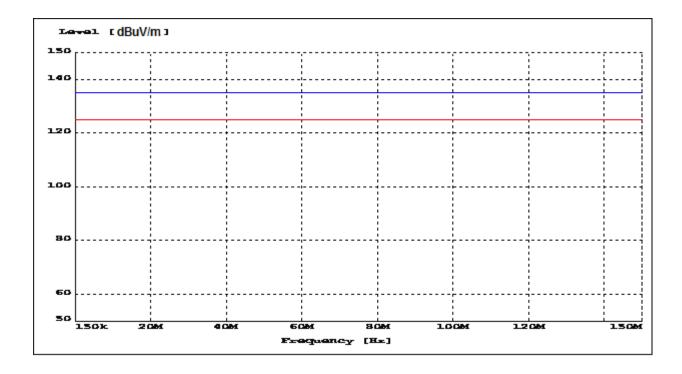
Test: Immunity Radiated Fields S3

Test Mode: Amplifier - Monitor: Speaker L

Operating Mode: AUX S/N: 72.8 dB

Frequency: - AF Level: 55.8 mW

Interf. Signal: Scan, K2 = 1.6 dB

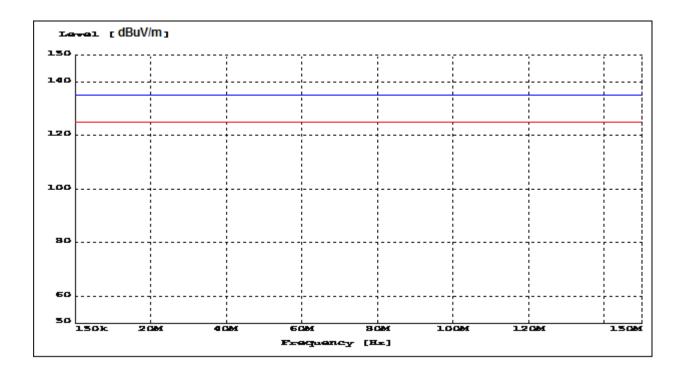


Test Mode: Amplifier - Monitor: Speaker R

Operating Mode: AUX S/N: 70.7 dB

Frequency: - AF Level: 56.5 mW

Interf. Signal: Scan, K2 = 1.6 dB



# 8. Keyed Carrier(S5)

Test Result : PASS

# 8.1 Limits for Immunity Measurement

Frequency	Level
(MHz)	dB(μV)/m
900	130

Test Voltage : 230V/50Hz

Tester : Jacky Kao

Ambient Temperature : 26°C Relative Humidity : 52%

**Atmospheric Pressure** : 1016mbar

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 8.2 Description of Performance Criteria

#### Performance criterion A

The equipment shall continue to operate as intended during the test. No change of actual operating state (for example change of channel) is allowed as a result of the application of the test. Multifunction equipment shall for each function meet the relevant requirements. Evaluation is carried out for audio and video functions. The equipment is supposed to operate as intended if the criteria of "Evaluation of audio quality" and/or "Evaluation of picture quality" are fulfilled.

#### Performance criterion B

The equipment shall continue to operate as intended after the test. No loss of function is allowed after the test when the apparatus is used as intended, but failures which are recovered automatically but which cause temporary delay in processing, are permissible. No change of actual operating state for example change of channel or stored data and settings is allowed as a result of the application of the test. During the test, degradation of performance is allowed.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. TEL.: 886-2-25984542 FAX.: 886-2-25984546

Page: 75 / 97

#### **Test Instruments** 8.3

Test Site and Equipment	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date	
Signal Generator	R&S	SML01/ 104230	Dec. 15, 2011	Dec. 15, 2013	
Signal Generator	R&S	SML02/ 101519	Dec. 15, 2011	Dec. 15, 2013	
Audio Analyzer	R&S	UPL/ 101285	Dec. 16, 2011	Dec. 16, 2013	
TV Test Transmitter	R&S	SFQ/ 100565	Dec. 14, 2011	Dec. 14, 2013	
TV Test Transmitter	R&S	SFM/ 100182	Dec. 14, 2011	Dec. 14, 2013	
TV Generator SECAM	R&S	SGSF/ 100062	Dec. 19, 2011	Dec. 19, 2013	
TV Generator NTSC	R&S	SGMF/ 100043	Dec. 19, 2011	Dec. 19, 2013	
TV Generator PAL	R&S	SGPF/ 100160	Dec. 19, 2011	Dec. 19, 2013	
MPEG2 Measurement Generator	R&S	DVG/ 100403	Dec. 19, 2011	Dec. 19, 2013	
50/75 Ohm Matching Pad	MINI-CIRCUITS	UNMD-5075/ 3 0605	Feb. 14, 2012	Feb. 14, 2013	
Power Meter	R&S	NRVD/ 837333/066	Dec. 3, 2012	Dec. 3, 2013	
RF Probe	R&S	URV5-Z4/ 100121	Oct. 18, 2012	Oct. 18, 2013	
Dual Directional Coupler	AR	DC6180/ 28730	Jan. 3, 2013	Jan. 3, 2014	
Power Amplifier	AR	150W1000/ 29167	NCR	NCR	
Bi-Log Antenna	EMCO	3142B/ 1716	NCR	NCR	
Isotropic E Field Probe	AR	FL7006/ 0336500	April 12, 2012	April 12, 2013	
Dual Channel Power Meter	R&S	NRVD/ 100499	Jan. 4, 2013	Jan. 4, 2014	

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

TEL.: 886-2-25984542 FAX.: 886-2-25984546

Page : 76 / 97

Test Site and Equipment	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date
Test Software	R&S	T80-K1/ Ver. 2.1	NCR	NCR
TR2 fully- anechoic chamber	ETS. LINDGREN	TR2/ 15353-R	Sept. 16, 2012	Sept. 16, 2013

#### Note:

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR : No Calibration Required.
- 3. The calibration date of the fully-anechoic chamber listed above is the date of Field Uniformity Calibration measurement.

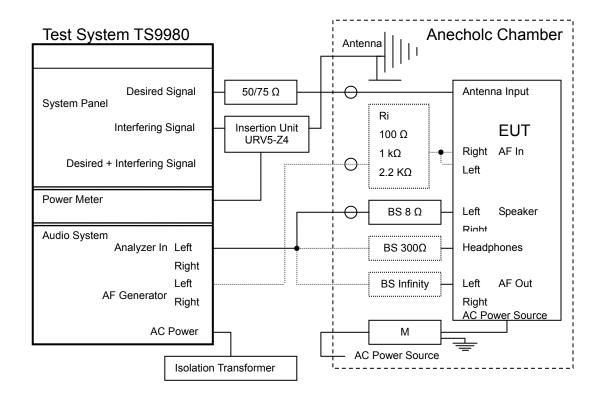
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### **Test Procedures** 8.4

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters and 3 meters away from the transmitting antenna in the fully anechoic chamber.
- c. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters and 3 meters away from the transmitting antenna in the fully anechoic chamber. Also if the floor-standing equipment which is capable of being stood on a non-conducting 0.8m high platform may be so arranged.
- d. All EUT's individual faces shall be fully enclosed by the "uniform area" and its wires shall be arranged parallel to the uniform area of the field.
- e. Before testing the EUT, the intensity of the established field strength is checked by placing the field sensor at a calibration grid point to give the calibrated field strength to measure the EUT.
- f. After the calibration has been verified, the test field can be generated using the values obtained from the calibration.
- g. Perform the test with the specified immunity level in the test frequency range and with the specified modulation type.
- h. The transmitting antenna is normally facing the front side of the EUT with vertical polarization to perform the test.
- i. The dwell time shall be not less than the time necessary for the EUT to be exercised and be able to respond.
- Record the performance of the EUT.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 8.5 Test Setup



# 8.6 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 8.7 Test Results

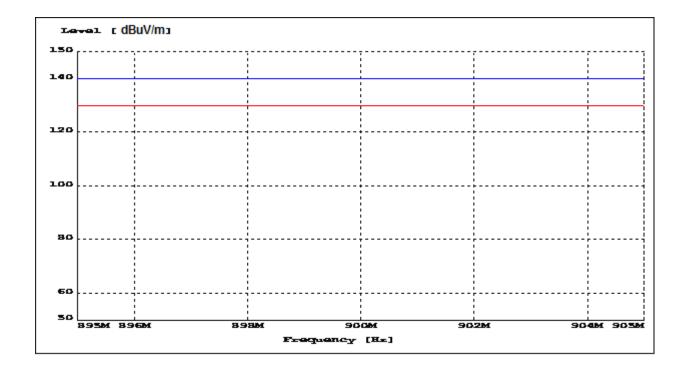
Test: Keyed Carrier S5

Test Mode: Amplifier - Monitor: Speaker R

Operating Mode: AUX S/N: 51.4 dB

Frequency: - AF Level: 60.7 mW

Interf. Signal: Scan

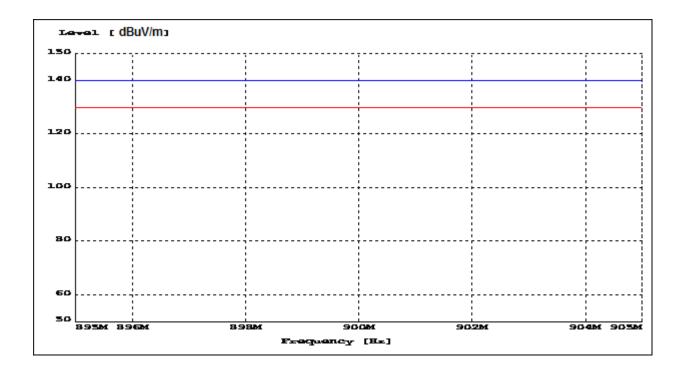


Test Mode: Amplifier - Monitor: Speaker L

Operating Mode: AUX S/N: 51.6 dB

Frequency: - AF Level: 94.7 mW

Interf. Signal: Scan



# 9. Electrostatic Discharge (ESD) Immunity Test

### 9.1 Specifications of Immunity Test Requirement

Product (Generic) Standard : EN 55020:2007+A11:2011

**Basic Standard** : IEC 61000-4-2:2008

Required Performance : B

**Test Level** : 2 (Contact discharge)

: 3 (Air discharge)

**Discharge Voltage** : Contact  $\rightarrow \pm 4kV$  (Direct / Indirect discharge)

: Air  $\rightarrow$  ±2 kV, ±4kV, ±8kV (Direct discharge)

Time Interval : 1 sec. minimum

Number of discharges : Minimum 20 times at each test point

Test Voltage : 230V/50Hz

Tester : Rick

Ambient Temperature : 23°C

Relative Humidity : 46%

**Atmospheric Pressure** : 1019mbar

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Page: 83 / 97

## 9.2 Description of Performance Criteria

#### Performance criterion A

The equipment shall continue to operate as intended during the test. No change of actual operating state (for example change of channel) is allowed as a result of the application of the test. Multifunction equipment shall for each function meet the relevant requirements. Evaluation is carried out for audio and video functions. The equipment is supposed to operate as intended if the criteria of "Evaluation of audio quality" and/or "Evaluation of picture quality" are fulfilled.

#### Performance criterion B

The equipment shall continue to operate as intended after the test. No loss of function is allowed after the test when the apparatus is used as intended, but failures which are recovered automatically but which cause temporary delay in processing, are permissible. No change of actual operating state for example change of channel or stored data and settings is allowed as a result of the application of the test. During the test, degradation of performance is allowed.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### **Test Instruments** 9.3

Test Site and Equipment	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date
Electrostatic Generator	EM TEST	DITO/ V1138110834	Dec. 25, 2012	Dec. 25, 2013
TR8	ETS.	TR8/	NCR	NCR
shielded room	LINDGREN	15353-C		

#### Note:

- 1. The calibrations are traceable to NML/ROC.
- NCR: No Calibration Required.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 9.4 **Test Procedures**

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters above the ground reference plane in the shielded room. Also a HCP (Horizontal Coupling Plane) which was connected to the ground reference plane via a cable with a  $470k\Omega$  resister located at each end was placed on the wooden table and isolated with the EUT by an insulating support 0.5mm thick. The ground reference plane shall project beyond the EUT or HCP by at least 0.5m on all sides.
- c. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters above the ground reference plane in the shielded room. The ground reference plane shall project beyond the EUT by at least 0.5m on all sides.
- d. Keep the EUT 1m away from all other metallic walls in the shielded room as the minimum distance.
- e. The static electricity discharges shall be applied only to those points and surfaces of the EUT which are accessible to persons during normal use. Contact discharge is the preferred test method and it is applied to the conductive surfaces of EUT and coupling planes. Air discharge shall be used where contact discharge cannot be performed and it is applied to the insulating surfaces of EUT.
- The discharge return cable of the generator shall be kept at a distance of at least 0.2m from the EUT whilst the discharge is being applied.
- g. The time interval between successive single discharges was at least 1 second.
- h. Select appropriate points of the EUT for contact discharge and put marks on it to indicate the tested point(s). Then start the contact discharge with the tip of the discharge electrode to touch the EUT before the discharge switch is operated.
- Use the round discharge tip of the discharge electrode to scan the EUT to select the points for air discharge. Then start the air discharge by approaching the discharge electrode as fast as possible to touch the EUT. After each discharge, the ESD generator shall be removed from the EUT.
- The indirect HCP discharge test is applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. TEL.: 886-2-25984542

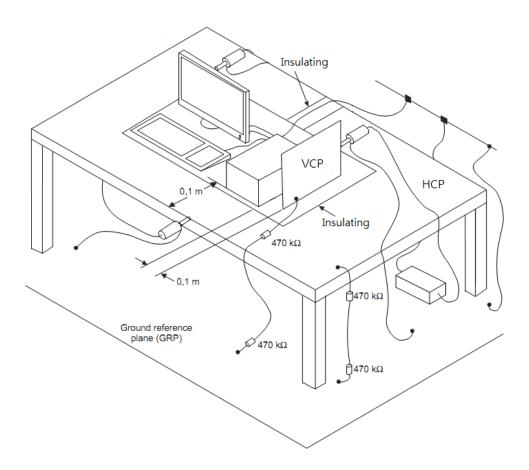
Report No.:O13-I210-1301-212

k. The indirect VCP (Vertical Coupling Plane) discharge test is applied to the center of one vertical edge of the coupling plane. The VCP, of dimensions 0.5m×0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. It shall be applied with sufficient different positions such that the four faces of the EUT are completely illuminated.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 9.5 Test Configurations



# 9.6 Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Page: 88 / 97

#### 9.7 Test Results

Test Mode : Normal

Discharge	Discharge Type of Label for		Performance		Result
Voltage (kV)	discharge	Dischargeable Points	Required	Observation	
±4	Contact	4~7,9	В	B(2)	Pass
±2	Air	1~3	В	A(1)	Pass
±4	Air	1~3	В	B(2)	Pass
+8	Air	1~3,8	В	A(1)	Pass
-8	Air	1~3,8	В	B(3)	Pass
±4	HCP-Bottom	Edge of the HCP	В	A(1)	Pass
±4	VCP-Front	Center of the VCP	В	A(1)	Pass
±4	VCP-Left	Center of the VCP	В	A(1)	Pass
±4	VCP-Back	Center of the VCP	В	A(1)	Pass
±4	VCP-Right	Center of the VCP	В	A(1)	Pass

# **Observation of Performance during Test**

- (1) Normal operation condition specified by manufacturer during the test.
- (2) The noise would appear from speaker while test is performing, it could self-recover after finishing the test.
- (3) The noise would appear from speaker while test is performing at test point "1", it could self-recover after finishing the test.

# Photographs of the Test Points on the EUT for ESD Test





CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.







CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.
TEL.: 886-2-25984542
FAX.: 886-2-25984546

## 10. Electrical fast transient / burst (EFT) Immunity Test

### 10.1 Specifications of Immunity Test Requirement

Product (Generic) Standard : EN 55020:2007+A11:2011

**Basic Standard** : IEC 61000-4-4:2004+A1:2010

Required Performance : B
Test Level : 2

Voltage Peak : ☑ ±1kV (on power supply port)

**Impulse Frequency**: 5kHz

Wave Shape of the Pulse  $(T_r/T_h)$ : 5ns / 50ns

Burst Duration : 15ms
Burst Period : 300ms
Time Duration : 1 min

Test Voltage : 230V/50Hz

Tester : Kent
Ambient Temperature : 25°C
Relative Humidity : 45%

**Atmospheric Pressure** : 1019mbar

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 10.2 Description of Performance Criteria

#### Performance criterion A

The equipment shall continue to operate as intended during the test. No change of actual operating state (for example change of channel) is allowed as a result of the application of the test. Multifunction equipment shall for each function meet the relevant requirements. Evaluation is carried out for audio and video functions. The equipment is supposed to operate as intended if the criteria of "Evaluation of audio quality" and/or "Evaluation of picture quality" are fulfilled.

#### Performance criterion B

The equipment shall continue to operate as intended after the test. No loss of function is allowed after the test when the apparatus is used as intended, but failures which are recovered automatically but which cause temporary delay in processing, are permissible. No change of actual operating state for example change of channel or stored data and settings is allowed as a result of the application of the test. During the test, degradation of performance is allowed.

CENTRAL RESEARCH TECHNOLOGY CO. 11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 10.3 Test Instruments

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Manufacturer	Serial No.	<b>Calibration Date</b>	Due Date	
EFT/Burst	EMC PARTNER	TRA2000IN6/	March 16, 2013	Marrah 40, 2044	
Simulator	EIVIC PARTNER	870	Watch 16, 2013	March 16, 2014	
Coupling	EMC PARTNER	CN-EFT1000/	NCR	NCR	
Clamp	EIVIC PARTNER	532	NCR	NCR	
Test Software	EMC PARTNER	TEMA/	NCR	NCR	
lest Software	EIVIC PARTINER	Ver. 1.86	NCR	NCR	
TR7	ETS.	TR7/	NCD	NCD	
shielded room	LINDGREN	15353-D	NCR	NCR	

#### Note:

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR: No Calibration Required.

CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

Page: 95 / 97

#### 10.4 Test Procedures

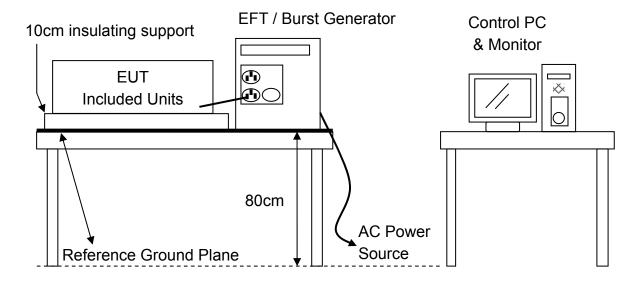
- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a wooden table with a height of 0.8 meters above the ground reference plane in the shielded room. The ground reference plane shall project beyond the EUT by at least 0.1m on all sides.
- c. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 0.1 meters above the ground reference plane in the shielded room. The ground reference plane shall project beyond the EUT by at least 0.1m on all sides.
- d. Keep the EUT 0.5m away from all other conductive structures, except the ground reference plane beneath the EUT as the minimum distance. Also if any, the minimum distance between the coupling clamp and all other conductive structures, except the ground reference plane beneath the coupling clamp and EUT shall be 0.5m.
- e. Keep the length of the power and signal lines, if required, between the coupling device and the EUT to be 1m or less. If a non-detachable supply cable more than 1m long, the excess length of this cable shall be gathered into a flat coil with a 0.4m diameter and situated at a distance of 0.1m above the ground reference plane.
- f. Connect the EUT's power source to the appropriate power through the coupling devices and perform the specified test level.
- g. If any, connect all the I/O signal, data and control lines between EUT and accessories/support units through the coupling devices and perform the specified test level.
- h. Record the performance of the EUT.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 10.5 Test Configurations

## **Power supply port Test**



# **10.6** Photographs of the Test Configurations

Please refer to the Attachment 1 of the present report.

CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

#### 10.7 Test Results

Test Mode : Normal

Injected Line	Voltage Peak	Injected	Performance		Result
injected Line	(kV)	Method	Required	Observation	(Pass/Fail)
L1 - L2 - PE	+1.0	Direct	В	B(1)	Pass
L1 - L2 - PE	-1.0	Direct	В	B(1)	Pass

# **Observation of Performance during Test**

(1) The noise would appear from speaker while test is performing, it could self-recover after finishing the test.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# Attachment 1 Photographs of the Test Configurations

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# **Contents**

1.	Conducted Emission Measurement	1
2.	Disturbance Power Measurement	2
3.	Harmonic Current & Voltage Fluctuations Emission Measurement	7
4.	Immunity Against RFI Voltage (S2a)	8
5.	Immunity Against Radiated RFI (S3)	9
6.	Keyed Carrier (S5)	. 10
7.	Electrostatic Discharge (ESD) Immunity Test	11
R	Flectrical fast transient / burst (FFT) Immunity Test	11

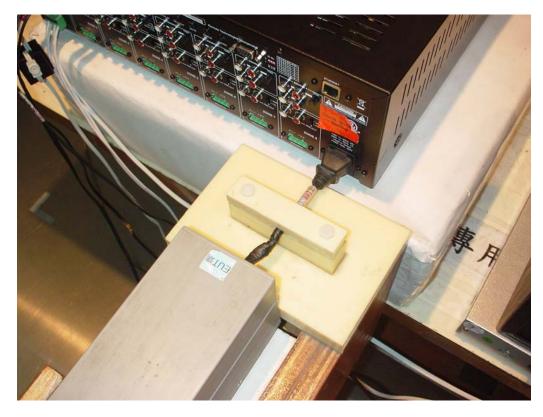
# 1. Conducted Emission Measurement





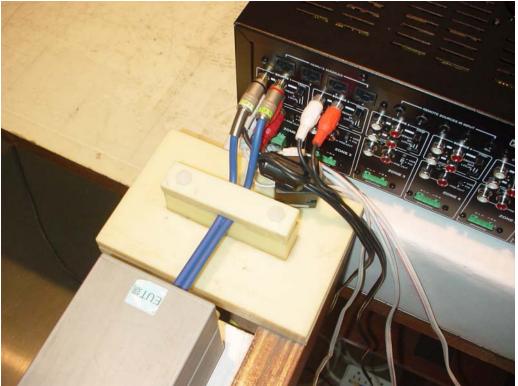
## 2. Disturbance Power Measurement



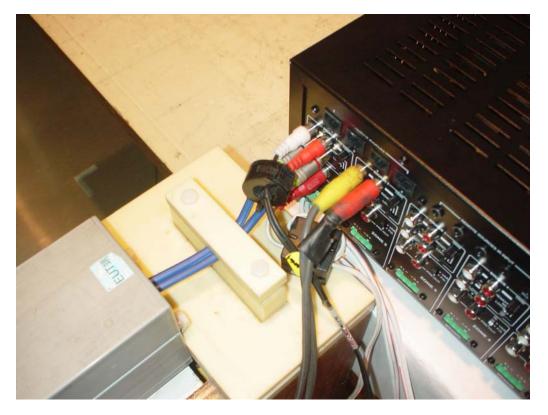


Page : A1-2 104. R.O.C.

















# 3. Harmonic Current & Voltage Fluctuations Emission Measurement





Page : A1-7

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 4. Immunity Against RFI Voltage (S2a)





# **Immunity Against Radiated RFI (S3)**





# 6. Keyed Carrier (S5)



CENTRAL RESEARCH TECHNOLOGY CO.
11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# 7. Electrostatic Discharge (ESD) Immunity Test



# 8. Electrical fast transient / burst (EFT) Immunity Test



CENTRAL RESEARCH TECHNOLOGY CO.

11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.

# Attachment 2 Photographs of EUT











